

Notice of References Cited		Application/Control No.	Applicant(s)/Patent Under Reexamination	
		10/583,030	LEFEBVRE ET AL.	
Examiner		Art Unit		Page 1 of 3
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	H	US-			
	I	US-			
	J	US-			
	K	US-			
	L	US-			
	M	US-			

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